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(54) (84) (30) (43) (73) (72)	MAGNESIUM FILM REFLECTORS MAGNESIUMSCHICHTREFLEKTOR REFLECTEURS A FILMS DE MAGNESIUM Designated Contracting States: AT BE CH DE DK ES FR GB GR IT LI LU NL SE Priority: 20.12.1989 US 454749 Date of publication of application: 21.10.1992 Bulletin 1992/43 Proprietor: VIRATEC THIN FILMS, INC. Fairbault, MN 55021 (US) Inventors: AUSTIN, Russell, R. Novato, CA 95120 (US) DICKEY, Eric, R. Beaverton, OR 97006-3477 (US)	 (74) Representative: Hall, Robert Leonard Dibb, Lupton, Broomhead, Fountain Precinct, Balm Green Sheffield S1 1RZ (GB) (56) References cited: DE-A- 3 005 621 JP-A- 1 131 624 US-A- 2 058 429 US-A- 3 565 671 US-A- 4 955 705 APPLIED OPTICS. vol. 12, no. 4, April 1973, NEW YORK US page 895 HACMAN D ET AL 'Reflectance of Vacuum Deposited Magnesium Films' DATABASE WPIL Section Ch, Week 8845, 1988 Derwent Publications Ltd., London, GB; Class L01, AN 88-320713 & SU-A-1390 205 JOURNAL OF THE OPTICAL SOCIETY OF AMERICA vol. 45, no. 11, November 1955, NEW YORK US pages 945 - 952 HASS G 'Filmed Surfaces for Reflecting Optics' H. K. Pulker, Coatings on Glass-THIN FILM SCIENCE AND TECHNOLOGY, 6 (1984), pp. 140, 141, 172, 213, 242, 243 and 407 - 414
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Note: Within nine months from the publication of the mention of the grant of the European patent, any person may give notice to the European Patent Office of opposition to the European patent granted. Notice of opposition shall be filed in a written reasoned statement. It shall not be deemed to have been filed until the opposition fee has been paid. (Art. 99(1) European Patent Convention).

Description

BACKGROUND OF THE INVENTION

5 1. Field of the Invention

The present invention relates generally to high reflectivity reflectors, and more particularly to magnesium reflectors. There are many optical systems in which light undergoes multiple reflections from the source or input stage to the detector or processor stage. Examples are cameras and document copiers. In these systems, it is desirable to provide
 reflecting surfaces having the highest possible reflectivity across the visible spectrum, <u>i.e.</u>, from a wavelength of about 425 nanometers (nm) to 675 nm. As many of these optical systems are found in consumer products, such reflectors are preferably inexpensive and capable of maintaining their high reflectance value for several years, generally in an uncontrolled environment.

15 2. Description of the Prior Art

Metal Film Reflectors

The most common mirrors or reflectors are formed from thermally-evaporated films of silver or aluminum. In their freshly-deposited state, the reflectivity of these films throughout the visible spectrum is relatively high. The reflectance value for a silver reflector ranges from a low of 93.9 percent at a wavelength of 400 nm to 98.7 percent at 700 nm. For aluminum film reflectors, the value is 92.6 percent at 400 nm, falling to 90.7 percent at 650 nm and 88.8 percent at 700 nm. If such reflective surfaces are left unprotected, their reflectivity or reflectance value decreases sooner or later due to corrosion. Aluminum forms a self limiting oxide film which causes its reflectivity to fall to a certain level between about 85 and 89 percent at 520 nm, <u>i.e.</u> at the middle of the visible spectrum. Thereafter, it stabilizes. Silver films will continue to corrode until they turn black. Their appearance also becomes blotchy and mottled. A reflector may be protected by depositing a film of a transparent dielectric material on the reflection surface. This, however, will reduce reflectivity.

Common household mirrors, known as second surface reflectors, are protected because they are observed through a glass sheet. Thus, they may be protected by covering the mirror's exposed side, which is not observed, with paints, lacquers, or thick films of other metals. However, even silver films used in such second surface reflectors will eventually corrode. Thus, silver mirrors are not often used for common, household applications, although they are still used for special scientific or military applications. Aluminum is now frequently used in second surface mirrors.

Partially-transmitting, silver reflector films, deposited by sputtering, are also used as low emissivity coatings or deicing coatings. These films may be completely sealed in an insulated glass window cavity or in a laminated windshield assembly. Thus, the possibility of corrosion is greatly reduced.

Multilayer Dielectric Reflectors

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Very high reflectivity reflectors can be produced by the deposition of multilayer dielectric interference stacks. These stacks comprise a number of transparent films of alternating high and low refractive index (n) materials wherein each film has a one-quarter wavelength optical thickness at a particular design wavelength. Mirrors for laser resonant cavities are produced in this manner. They can have reflectivity values as high as 99.9 percent at wavelengths near the red end of the visible spectrum. Their reflectivity value decreases at longer and shorter wavelengths. For instance, for a thirteen film structure having high refractive index films of n = 2.35 and low refractive index films of n = 1.38, all films having a one-quarter wavelength optical thickness at 500 nm, a value of 99 percent reflectivity or greater can be maintained only over a wavelength range of approximately 12 nm.

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over a wavelength range of approximately 12 nm. The reflectivity range can be extended by combining two or more stacks, with the stack thicknesses adjusted so that the effective reflection regions overlap and cover the entire visible spectrum. Typically, such reflectors require 25

or more films. However, these structures are uneconomical for large area applications. 50

Dielectric Enhanced Reflectors

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The reflectivity of metals, particularly those having a very high reflectivity, can be significantly enhanced by the addition of as few as two transparent dielectric films. In such structures, the dielectric film next to the metal film has a low refractive index while the other dielectric film has a high refractive index. See Hass, "Filmed Surfaces for Reflecting Optics", 45 J. Opt. Soc. Am. 945-52, (1955). For example, the reflectivity of a freshly-deposited aluminum film may be increased from 91.6 to about 97 percent, at a wavelength of 550 nm, by the use of low refractive index layer, e.g. magnesium fluoride (n=1.38), and a high refractive index layer, e.g. titanium dioxide (n=2.35) or zinc sulfide. The addition

of a second pair of high and low dielectric layers can boost the reflectivity value even further, <u>e.g.</u>, to approximately 99 percent. However, the cost of the structure also increases. Further, the bandwidth of the high reflectivity zone becomes limited, as previously described. Indeed, outside the zone of high reflectivity, the reflectivity is less than that of the bare metal film. This is illustrated in Figure 1 which shows the spectral response curves for aluminum reflectors having two (curve 10) and four (curve 12) dielectric layers. The reflectivity of bare aluminum (curve 14) is shown for comparison. The designs of the enhanced structures of Figure 1 are shown in Table 1.

Two Dielectric Layers					
Layer No.	Refractive Index	Optical Thickness (at λ = 500 nm)			
1	2.35	0.264 λ			
2	1.38 0.233 λ				
3	Aluminum	Opaque (>150 nm thick)			
Four Dielectric Layers					
Layer No.	Refractive Index	Optical Thickness (at λ = 500 nm)			
1	2.35	0.255 λ			
2	1.38	0.271 λ			
3	2.35	0.261 λ			
4	1.38	0.229 λ			
5 Aluminum		Opaque (>150 nm thick)			

TABLE 1

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It is believed that most front surface enhanced reflectors include aluminum enhanced by one dielectric layer pair. Higher quality mirrors are also made that include an aluminum film enhanced by two dielectric layer pairs. One dielectric layer pair enhanced mirrors generally have a reflectivity of about 94 percent between 425 nm and 675 nm. Two dielectric layer pair enhanced mirrors have a reflectivity greater than 97 percent in the same wavelength range.

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Higher reflectance values for a given enhancement can be obtained if silver is used as the base film. However, due to its cost and corrosion problems, silver-based enhanced reflectors are generally undesirable.

A more detailed description of these devices and their design techniques are given in <u>Thin Film Optical Filters</u>, MacLeod, 2d. ed., Ch. 4, pp. 138-46; Ch. 5, pp. 164-79 (1986)

35 Reflectance Values for Magnesium

The optical constants of bulk metals, including magnesium, were reported by Drude in 39 <u>Ann. Physik</u> 481 (1890). The measurements are at one wavelength only, 589 nm, the sodium "D" lines. For magnesium, they show a reflectivity of 93.1 percent at that wavelength.

The reflectivity values for evaporated magnesium films in the visible spectral range were first reported by O'Bryan in 26 <u>J. Opt. Soc. Am.</u> 122 (1936). These values range from 68 percent at a wavelength of 405 nm to 88 percent at a wavelength of 578 nm. See also the <u>American Institute of Physics ("AIP") Handbook</u>, 3rd. ed., Ch. 6, pp. 124-55 (1982), which is used by many practitioners in the optical thin film art as a source of optical constants for metals. These values indicate that evaporated magnesium is unsuitable for high reflectivity reflectors. Specifically, a high reflectivity

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reflector should have a reflectance value of at least in excess of about 90 percent across the visible spectrum. Applied Optics, vol. 12, No. 4, April 1973, page 895 discloses the production of mirror coatings of magnesium of 99.99 percent purity having reflectivity values up to 93 percent over a substantial part of the visible spectrum. The

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A general object of the present invention is to provide a reflector that has a reflectivity and transparency greater than an aluminium reflector.

A more specific object of the present invention is to provide a reflector having at least one layer of magnesium and a reflectivity across the visible spectrum of at least about 92 percent.

55 SUMMARY OF THE INVENTION

According to an aspect of the present invention there is provided a method as defined in Claim 1. Preferred features of the method are defined in claims 2 to 5.

coatings are deposited on glass substrates in an ultra high vacuum coater.

According to another aspect of the invention, there is provided a reflector as defined in Claim 6. According to a further aspect of the invention, there is provided a reflector according to Claim 7.

BRIEF DESCRIPTION OF THE DRAWINGS

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Figure 1 is a graph illustrating the spectral response curves for enhanced aluminum reflectors having two and four dielectric layers.

Figure 2 is a graph illustrating the spectral response of bare NBS standard aluminium and a freshly-sputtered bare magnesium film in accordance with the present invention.

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Figure 3 is a graph illustrating the reflectance values for a magnesium film of the present invention enhanced by one and two dielectric layer pairs.

Figure 4 shows the reflection and transmission values of a 90 nm thick magnesium film.

Figure 5 shows the reflection and transmission response curves for a low E system using magnesium and titanium dioxide

Figure 6 shows the transmission and reflection response curves for a five layer low E system using magnesium and titanium dioxide.

DETAILED DESCRIPTION OF THE PREFERRED EMBODIMENTS

20 Films of the pure magnesium metal were sputtered in an inert atmosphere of pure argon gas. The reflectivity of these films was measured against new National Bureau of Standards (NBS) standard aluminum films, and it was found that the reflectivity of the magnesium films was considerably higher than the aluminum films over most of the visible spectrum. The results of these measurements are shown by the spectral response curves of Figure 2. Curve 18 shows the reflectivity of the bare NBS standard aluminum film, and curve 20 shows the freshly-sputtered bare magnesium film.

25 As can be seen from these measurements, the reflectivity of the magnesium film approaches 95 percent in the middle of the visible spectrum. This is higher than the value reported by Drude, discussed above, for polished magnesium metal.

In order to determine the optical properties of the magnesium films, two magnesium films, one approximately 9 nm thick and the other approximately 220 nm thick, were deposited on a glass substrate. These films were sufficiently thin 30 so as to be transparent to visible light as well as reflective. The optical constants of these films were determined by measuring the transmission and reflectance values. Using these values, the maximum reflectivity for an opaque magnesium film was calculated. The calculated values agreed with the measured values for the opaque magnesium film to within 0.5 percent at wavelengths between 400 and 700 nm. This confirmed that the high reflectivity that was measured was real to within the 0.5 percent accuracy. The optical constants and reflectivity values for the opaque magnesium film

35 are shown in Table 2, along with the previously reported values by O'Bryan and Drude.

TABLE 2

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Results for DC Magnetron Sputtered Magnesium Films

		Optical <u>Constants</u>		Maximum	
	<u>Wavelength (nm)</u>	<u>n</u>	<u> </u>	<u>Reflectivity (%)</u>	
45	400	0.34	3.75	91.42	
	440	0.29	4.18	93.94	
	48 0	0.31	4.60	94.58	
	520	0.37	5.02	94.53	
50	560	0.43	5.43	94.54	
	600	0.49	5.85	94.62	
	640	0.56	6.26	94.61	
	680	0.61	6.67	94.82	

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	Optical <u>Constants</u>		Maximum	
<u>Wavelength (nm)</u>	<u>n</u>	<u>k</u>	<u>Reflectivity (%)</u>	
404.6	0.52	2.05	68.1	
435.8	0.52	2.65	77.7	
491.6	0.53	2.92	80.5	
546.1	0.57	3.47	84.3	
578.0	0.48	3.71	88.0	

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Values for Evaporated Magnesium Films AIP Handbook - O'Bryan

Values for Bulk Magnesium AIP Handbook - Drude

20		Optical <u>Constants</u>		Maximum	
20	<u>Wavelength (nm)</u>	<u>n</u>	<u> </u>	<u>Reflectivity (</u>	(8)
	589	0.37	4.42	93.1	

The fact that the optical constants for the very thin magnesium films agreed with those of opaque films indicates that little or no oxidation of the magnesium was taking place during the deposition process.

As far as can be determined, there has not been a report in the literature which discloses or even suggests the optical properties of magnesium discussed above. The magnesium films of the present invention have a reflectivity across the visible spectrum significantly greater than that of aluminum. Their reflectivity approaches that of silver, which, previously, was believed to be the only metal with a reflectivity in the visible spectrum greater than aluminum.

- ³⁰ The films of the present invention may be prepared in an Airco Coating Technology, Fairfield, California, "in line" sputtering system Model D1. This system is capable of coating substrates up to one meter wide and two meters long. In this system under normal operating conditions, the substrates being coated move continually under DC magnetron sputtering cathodes, which are the deposition sources. The magnesium films can be prepared under normal production conditions. Thus, large areas films can be produced at low cost.
- The sputtering sources were formed by bonding tiles of the magnesium alloy AZ 31 B onto the copper backing plates of the cathodes. This alloy is about 94 percent magnesium and is commercially available from Plasmaterials, 10046 Nantucket Dr., San Ramon, Ca. It may contain up to 3 percent aluminum, 1 percent zinc and about 0.2 percent magnesie. The use of this alloy is not believed to have any particular influence on the optical properties of the sputtered magnesium film, although it may influence the oxidation resistance of the film. Importantly, the magnesium content of any alloy used must be such that the resulting magnesium layer or film is at least about 90 percent pure magnesium.

The base pressure in the coating system was 5×10^{-6} Torr. The sputtering pressure in the vicinity of the cathodes was 1.03×10^{-3} Torr. The sputtering gas was argon and the gas flow rate gas was 90 standard cubic centimeters per minute (sccm). The power applied to the cathodes was 23 KW at a voltage of -583 V. Substrates being coated were moved past the cathodes at a line speed appropriate to yield the desired thickness.

⁴⁵ A 600 nm thick film, which is thick enough to yield a full reflector, was deposited at the above conditions and at a line speed of 25 inches per minute. A 9 nm thick film was produced by reducing the power to 5 KW and increasing the line speed to 200 inches per minute.

Also, it is believed that similar results can be obtained by sputter depositing the magnesium by techniques other than DC magnetron sputtering such as by RF sputtering. Additionally, such results may be obtained by evaporating the films at extremely low pressures, <u>i.e.</u>, less than 1X10⁻⁷Torr. This would prevent the magnesium from forming an oxide during the deposition process, thereby preventing low reflection values.

The magnesium films can be used as a substitute for aluminum or silver in reflecting film structures. The magnesium films can also be used in visibly-transparent, IR-reflecting structures, commonly called low emissivity (Low E) or solar control coatings.

As shown by Figure 2, in a first surface reflector, the reflectivity of an unprotected magnesium film is higher than the NBS standard aluminum film. At a wavelength of 500 nm, the reflectivity is approximately 94.5 percent compared with aluminum at approximately 92 percent.

For second surface reflectors, it is expected that the reflection value from the glass to air surface for a magnesium

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film, deposited in accordance with the sputter techniques described above, will be about 92.2 percent. This is greater than aluminum which should have a reflectivity of about 88.6 percent as computed using the accepted optical properties of aluminum. The reflectivity of the magnesium film also compares favorably with silver which would have a second surface reflectivity of above 97.15 percent. These values are all at a wavelength of 500 nm.

- ⁵ The performance of dielectric enhanced reflectors may also be improved by the use of magnesium films. Figure 3 shows the values for magnesium films enhanced by one (curve 22) and two (curve 24) dielectric layer pairs. As can be seen by comparing this data with the data of Figure 1, the reflectivity of the two dielectric layer enhanced magnesium reflector is almost the same as the four dielectric layer enhanced aluminum reflector.
- The designs for the structures of Figure 3 are shown in Table 3. The choice of the refractive index values is somewhat arbitrary. Other values could be substituted for one or more of the films to achieve the enhancement albeit with different thickness and slightly different results. Similarly, the thickness of the dielectric films may be modified to produce a different reflection response with wavelength.

TABLE 3

	(Layer	Magnesium Enha s are numbered	anced Reflectors from the air boundary)		
20	One Pair				
20	Layer No.	Refractive Index	Optical Thickness (at $\lambda = 500 \text{ nm}$)		
25	1 2 3	2.35 1.38 Magnesium	0.259 λ 0.223 λ Opaque (>150 nm thick)		
30	(Table 3 (Continued) Tw	o Pairs		
35	<u>Layer No</u> .	Refractive Index	Optical Thickness (at $\lambda = 500 \text{ nm}$)		
40	1 2 3 4	2.35 1.38 2.35 1.38	0.251 λ 0.274 λ 0.248 λ 0.228 λ		
	5	Magnesium	Opaque (>150 nm thick)		

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There is a further important implication of the present invention which relates to the low absorption of the sputtered magnesium film. One reason that the reflectivity of the magnesium film is significantly higher than aluminum is that the absorption of the magnesium film is significantly less than aluminum. Thus, not only are magnesium films highly reflective for applications where reflectivity in the visible spectrum is important, but in the form of thin films, they are also transparent in the same spectral region. This was verified experimentally, and the reflection (curve 26) and transmission (curve 28) responses of a 90 nm thick magnesium film are shown in Figure 4.

- This high transparency property in the visible spectrum is particularly useful in so-called low E systems for architectural applications. These are systems in which a thin, partially-transmitting, metal film, usually silver, is bounded on either side with dielectric layers to reduce visible reflection from the film and increase transparency. The metal film must be thick enough to be highly conductive and have a high reflectivity at infrared wavelengths so that it will reflect heat, for instance, back into a building where the low E coatings are deposited on windows. The design principles for this type of device are discussed by MacLeod in <u>Thin Film Optical Filters</u>, 2d. ed., Ch. 7, pp. 295-308 (1986).
 - Using the optical properties measured for magnesium films, the performance of a low E layer structures having one magnesium film have been computed, as represented in Figure 5. Curve 30 is the reflection response curve and curve 32 is the transmission response curve. Figure 6 shows the computed performance of structures with two magnesium films. Both the reflection and transmission response curves 34 and 36, respectively, are shown.

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The designs of the structures of Figures 5 and 6 are shown in Table 4. The choice of titanium dioxide (TiO₂) as the dielectric material is somewhat arbitrary, and it is recognized that other dielectric materials with different refractive index values could be used singly or in combination such structures. Similarly, it is recognized that the thicknesses of the dielectric and metal films may be modified to produce different reflection and transmission responses with wavelength.

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TABLE 4

Magnesium and Titanium Dioxide Low E Systems (Layers are numbered from the air boundary)

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One Magnesium Film

Laver No.	<u>Material</u>	<u>Physical Thickness (nm)</u>
1	Ti02	40
2	Mg	6
3	Ti02	40

Two Magnesium Films

	Layer No.	<u>Material</u>	<u>Physical Thickness (nm)</u>
25	1	TiO ₂	37
	2	Mg	6
	3	TiO ₂	72
	4	Mg	6
	5	TiO ₂	33

³⁰ As can be seen from the above, films of magnesium metal are more reflective and more transparent than aluminum in the visible spectral region. The magnesium films of the present invention can be incorporated into a number of reflective and transmissive optical devices and filters.

The present invention has been described in terms of a number of embodiments. The invention, however, is not limited to the embodiments depicted and described. Rather, the scope of the invention is defined by the appended claims.

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Claims

1. A method of producing a reflector, the method comprising producing a magnesium layer on a substrate to form a light-reflecting surface, characterised in that said magnesium layer is sputtered onto said substrate, and wherein the sputtering parameters are chosen such that said magnesium layer is at least about 90 percent magnesium and has a reflectivity value substantially across the visible spectrum of at least about 92 percent.

2. A method according to Claim 1, wherein said magnesium layer is sputter-deposited on a transparent substrate.

3. A method according to Claim 1 or 2, wherein said magnesium layer is sputter-deposited in an inert gas atmosphere.

4. A method according to Claim 3, wherein said magnesium layer is produced by DC magnetron sputtering in an inert gas atmosphere.

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5. A method according to Claim 3 or 4, wherein said inert gas is argon.

- 6. A reflector comprising at least one layer of material including magnesium defining a light reflecting surface, characterised in that the reflector is a second surface reflector, and said layer of material is sputter deposited and includes at least about 90 percent magnesium and has a reflectivity value substantially across the visible spectrum of at least about 92 percent.
- 7. A reflector comprising at least one layer of material including magnesium defining a light reflecting surface, char-

acterised in that the reflector is a dielectric enhanced reflector and said layer of material is sputter-deposited and includes at least about 90 percent magnesium and has a reflectivity value across the visible spectrum of at least about 92 percent.

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Patentansprüche

- 1. Verfahren zur Herstellung eines Reflektors, bei welchem zum Ausbilden einer lichtreflektierenden Oberfläche eine Magnesiumschicht auf einem Substrat hergestellt wird, dadurch gekennzeichnet, daß die Magnesiumschicht auf das Substrat gesputtert wird, wobei die Sputterparameter so gewählt werden, daß die Magnesiumschicht aus wenigstens ungefähr 90% Magnesium besteht und im wesentlichen über dem sichtbaren Spektrum einen Wert des Reflexionskoeffizienten von wenigstens ungefähr 92% aufweist.
- 2. Verfahren nach Anspruch 1, bei dem die Magnesiumschicht auf ein transparentes Substrat aufgesputtert wird.
 - 3. Verfahren nach Anspruch 1 oder 2, bei dem die Magnesiumschicht in einer inerten Gasatmosphäre aufgesputtert wird.
- 4. Verfahren nach Anspruch 3, bei dem die Magnesiumschicht in einer inerten Gasatmosphäre durch Gleichstrommagnetronsputtern hergestellt wird.
 - 5. Verfahren nach Anspruch 3 oder 4, bei dem das inerte Gas Argon ist.
- 6. Reflektor mit wenigstens einer Materialschicht die Magnesium beinhaltet und eine lichtreflektierende Oberfläche bildet, dadurch gekennzeichnet, daß der Reflektor ein auf einer zweiten Oberfläche verspiegelter Reflektor ist und die Materialschicht durch Sputtern aufgetragen ist und wenigstens ungefähr 90% Magnesium enthält und im wesentlichen über dem sichtbaren Spektrum einen Wert für den Reflexionskoeffizienten von wenigstens ungefähr 92% aufweist.
- 30 7. Reflektor mit wenigstens einer Materialschicht, die Magnesium enthält und eine lichtreflektierende Oberfläche bildet dadurch gekennzeichnet daß der Reflektor ein dielektrisch verbesserter Reflektor ist und die Materialschicht durch Sputtern aufgetragen ist und wenigstens ungefähr 90% Magnesium enthält und über dem sichtbaren Spektrum einen Wert des Reflexionskoeffizienten von wenigstens ungefähr 92% aufweist.
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Revendications

- Procédé de fabrication d'un réflecteur, le procédé comprenant la production d'une couche de magnésium sur un substrat pour former une surface réfléchissant la lumière, caractérisé en ce que ladite couche de magnésium est pulvérisée sur ledit substrat, et dans lequel les paramètres de pulvérisation sont choisis de sorte que la couche de magnésium comporte au moins environ 90% de magnésium et a une valeur de réflectivité sensiblement dans le spectre visible d'au moins 92%.
- Procédé selon la revendication 1, dans lequel ladite couche de magnésium est pulvérisée sur un substrat transpa rent.
 - 3. Procédé selon l'une des revendications 1 et 2, dans lequel ladite couche de magnésium est pulvérisée dans une atmosphère de gaz inerte.
- 50 **4.** Procédé selon la revendication 3, dans lequel ladite couche de magnésium est produite par un magnétron à courant continu de pulvérisation dans une atmosphère de gaz inerte.
 - 5. Procédé selon l'une des revendications 3 et 4, dans lequel le gaz inerte est de l'argon.
- 6. Réflecteur comprenant au moins de couche de matériau comprenant du magnésium définissant une surface réfléchissant la lumière, caractérisé en ce que ledit réflecteur est un réflecteur à surface secondaire, et ladite couche de matériau est déposée par pulvérisation et comporte environ 90% de magnésium et a une valeur de réflectivité sensiblement dans le spectre visible d'au moins environ 92%.

7. Réflecteur comprenant au moins une couche de matériau comprenant du magnésium définissant une surface réfléchissant la lumière, caractérisé en ce que le réflecteur est un réflecteur enrichi en diélectrique et ladite couche de matériau est déposée par pulvérisation et comporte au moins environ 90% de magnésium et a une valeur de réflectivité dans le spectre visible d'au moins environ 92%.

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REFLECTANCE (%)



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REFLECTANCE (%)







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REFLECTANCE/ TRANSMISSION







FIG.-6

REFLECTANCE / TRANSMISSION